

Lamdamap 9th International Conference, Tuesday 30th June – Thursday 2nd July 2009

Session 5: Advanced Manufacturing & Metrology using Laser Techniques

Orals - Wednesday 1st July 2009, 11:30- 12:30

Posters- Wednesday 1st July 2009, 12:30-13:00

Paper Title	Title	Name(s)	Surname	Affiliation	Ref. No
Development of a metrological atomic force microscope at KULeuven	Dip- Ing	Jan	Piot	Katholieke Universiteit Leuven	O5.1
Ultra precision machining and metrology for low uncertainty determination of the Boltzmann Constant	Mr	Paul	Morantz	Cranfield University	O5.2
Concept of a new 3D- probing system for micro components	Mr	Thomas	Liebrich	Inspire / ETH Zurich	O5.3
A 2D contact-type measuring system for profile measurement using laser interferometer	Prof.	Yung-Tien	Liu	National Kaohsiung First University of Science and Technology	P5.1
An Experimental Evaluation of Dynamic Tracking Performance of iGPS and Laser Tracker	Mr	Zheng	Wang	University of Bath	P5.2